

## 5.2 Radiated power of the fundamental wave

For test instruments and accessories used see section 6 Part CPR 2.

### 5.2.1 Description of the test location

Test location: OATS1

Test distance: 3 metres

### 5.2.2 Photo documentation of the test set-up



### 5.3 Radiated emissions (electric field) 30 MHz – 40 GHz

For test instruments and accessories used see section 6 Part SER 2, SER 3.

#### 5.3.1 Description of the test location

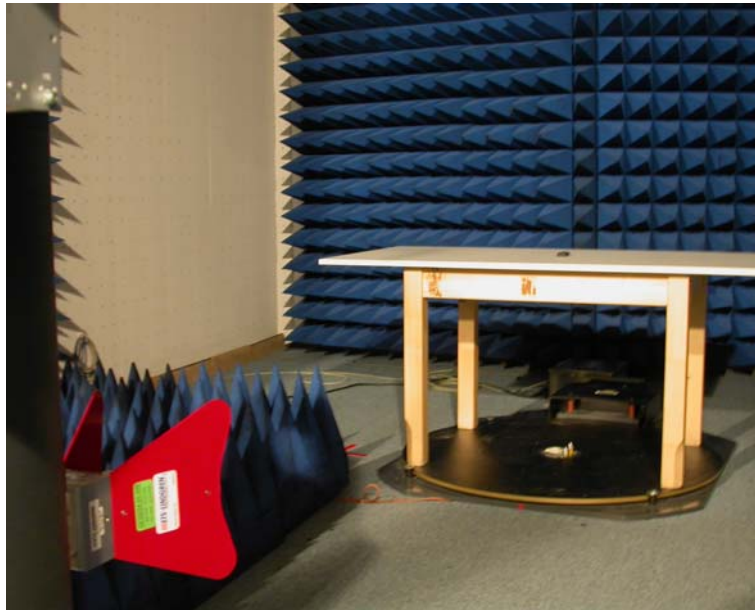
Test location: OATS1  
Test location: Anechoic Chamber A2

Test distance: 3 metres

#### 5.3.2 Photo documentation of the test set-up



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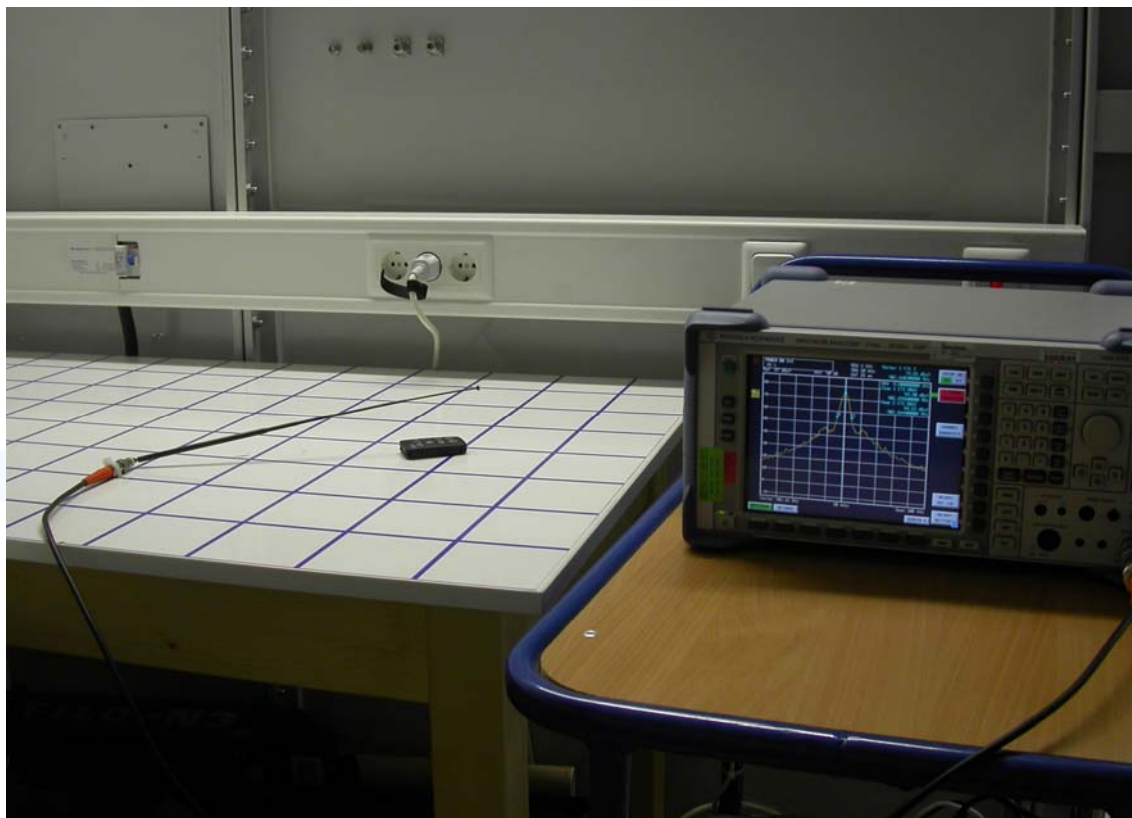
## 5.4 Emission Bandwidth

For test instruments and accessories used see section 6 Part MB.

### 5.4.1 Description of the test location

Test location:                Shielded Room S4

### 5.4.2 Photo documentation of the test set-up





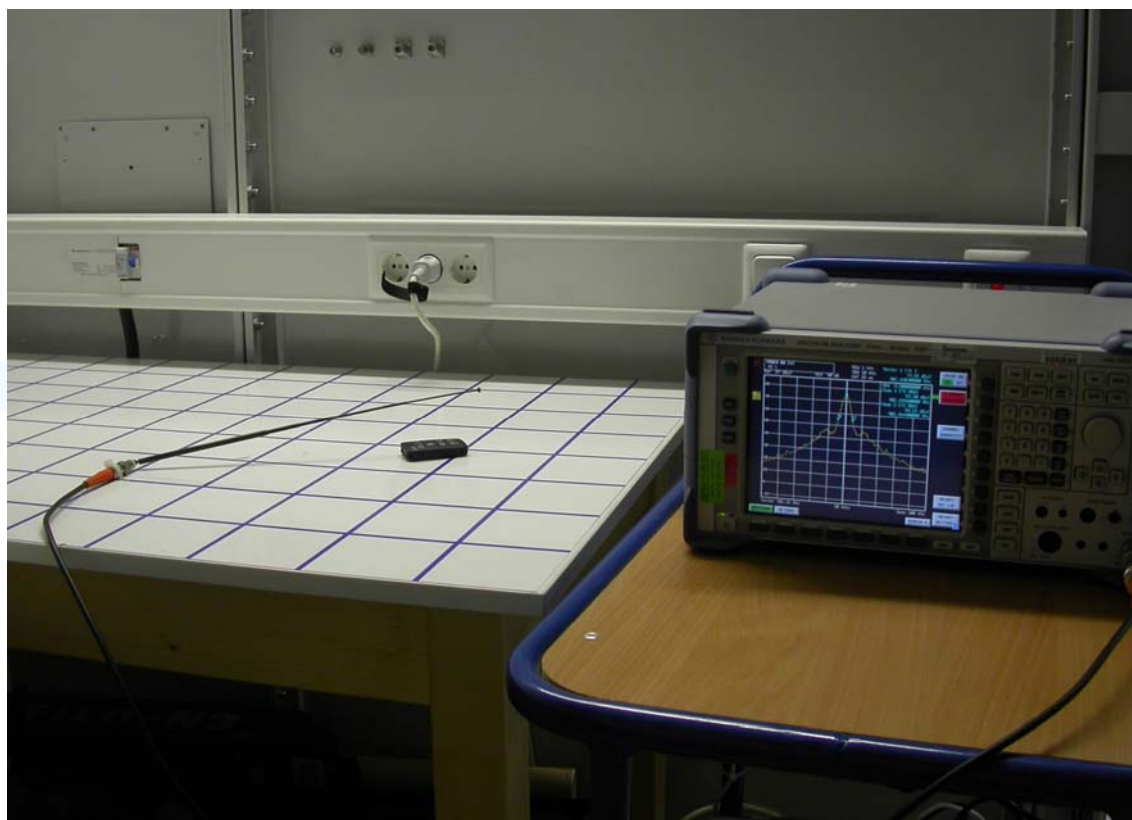
## 5.5 Band edge test

For test instruments and accessories used see section 6 Part MB.

### 5.5.1 Description of the test location

Test location: Shielded Room S4

### 5.5.2 Photo documentation of the test set-up



### 5.5.3 Description of Measurement

The EuT was connected to the spectrum analyzer with a suitable attenuator. The span of the spectrum analyzer was set wide enough to capture the peak level of the emission operating on the channel closest to the bandedge, as well as any modulation products which fall outside of the authorized band of operation. The highest amplitude appearing on spectral display was measured and it was set as the reference level for the emission mask. It was allowed the trace to stabilize and after then it was set the emission mask on the reference level to show the compliance with the bandedge requirements.

Further settings on the spectrum analyzer:

RBW:	$\geq 1\%$ of the span
VBW:	$\geq$ RBW
Sweep:	Auto
Detector function:	Peak

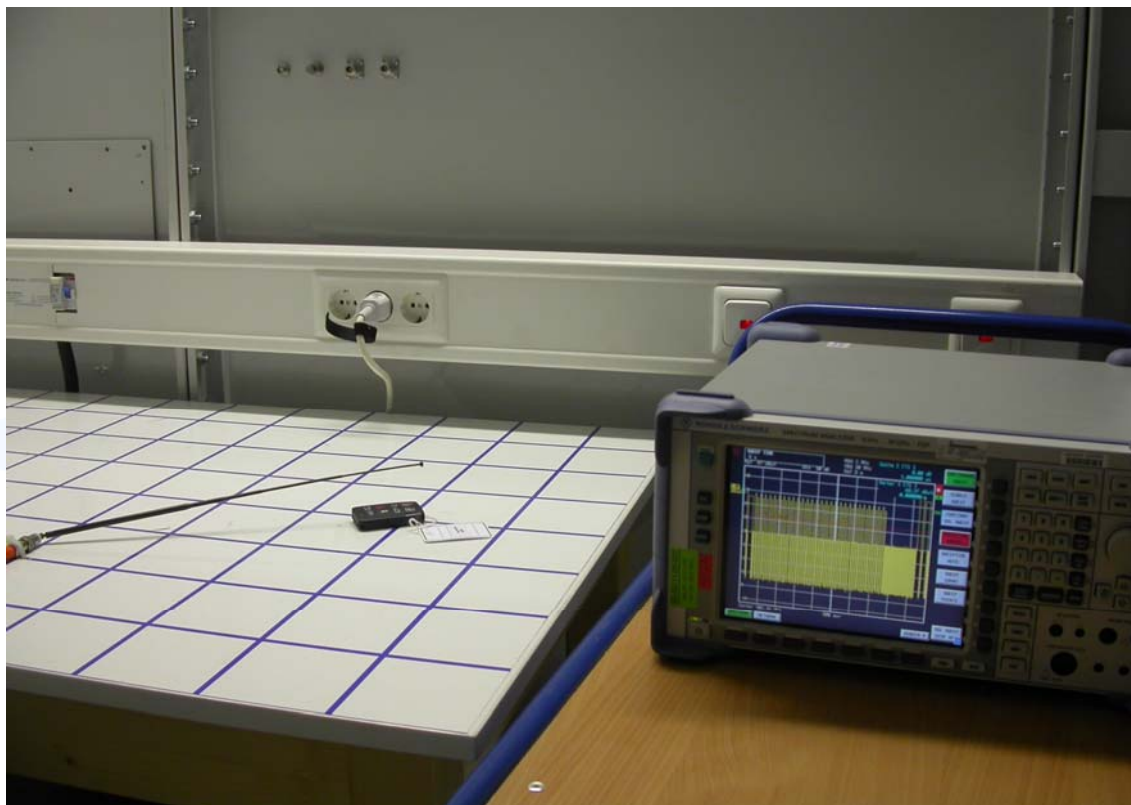
## 5.6 Correction for Pulse Operation (Duty Cycle)

For test instruments and accessories used see section 6 Part DC.

### 5.6.1 Description of the test location

Test location:                      Shielded Room S4

### 5.6.2 Photo documentation of the test set-up



### 5.6.3 Description of Measurement

The Duty cycle factor, expressed in dB, is arrived by taking the following formula:

$$KE = 20 \log [(t_{iB} \cdot p) / T_w]$$

KE: pulse operation correction factor [dB]  
 $t_{iw}$  pulse duration for one complete pulse track [msec]  
 $t_{iB}$  pulse duration for one pulse [µsec]  
 $T_w$  a period of the pulse track [msec]  
 $p$  number of pulses in one train

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## 5.9 Receiver radiated emissions (electric field) 30 MHz - 40 GHz

For test instruments and accessories used see section 6 Part SER2 and SER3.

### 5.9.1 Description of the test location

Test location: OATS1  
Test location: Anechoic Chamber A2

Test distance: 3 metres

### 5.9.2 Photo documentation of the test set-up



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